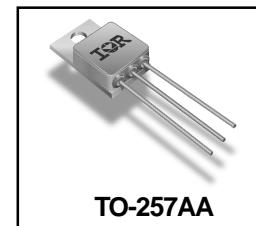


**IRFY240C,IRFY240CM**  
**200V, N-CHANNEL**  
**HEXFET® MOSFET TECHNOLOGY**

**Product Summary**

Part Number	R <sub>Ds(on)</sub>	I <sub>D</sub>	Eyelets
IRFY240	0.18 Ω	16A	Glass
IRFY240M	0.18 Ω	16A	Glass

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.



**TO-257AA**

**Features:**

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Ceramic Eyelets
- Ideally Suited For Space Level Applications

**Absolute Maximum Ratings**

	Parameter		Units
I <sub>D</sub> @ V <sub>GS</sub> = 10V, T <sub>C</sub> = 25°C	Continuous Drain Current	16	A
I <sub>D</sub> @ V <sub>GS</sub> = 10V, T <sub>C</sub> = 100°C	Continuous Drain Current	10.2	
I <sub>DM</sub>	Pulsed Drain Current ①	64	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Max. Power Dissipation	100	W
	Linear Derating Factor	0.8	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	±20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy ②	580	mJ
I <sub>AR</sub>	Avalanche Current ①	16	A
E <sub>AR</sub>	Repetitive Avalanche Energy ①	10	mJ
dV/dt	Peak Diode Recovery dV/dt ③	5.0	V/ns
T <sub>J</sub> T <sub>STG</sub>	Operating Junction Storage Temperature Range	-55 to 150	°C
	Lead Temperature	300(0.063in./1.6mm from case for 10 sec)	
	Weight	4.3 (Typical)	g

For footnotes refer to the last page

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (Unless Otherwise Specified)**

	Parameter	Min	Typ	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	200	—	—	V	$V_{GS} = 0\text{V}, I_D = 1.0\text{mA}$
$\Delta BVDSS/\Delta T_J$	Temperature Coefficient of Breakdown Voltage	—	0.29	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1.0\text{mA}$
RDS(on)	Static Drain-to-Source On-State Resistance	—	—	0.18	$\Omega$	$V_{GS} = 10\text{V}, I_D = 10.2\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
$g_f$	Forward Transconductance	6.1	—	—	S ( $\text{mS}$ )	$V_{DS} > 15\text{V}, I_{DS} = 10.2\text{A}$ ④
IDSS	Zero Gate Voltage Drain Current	—	—	25	$\mu\text{A}$	$V_{DS} = 160\text{V}, V_{GS} = 0\text{V}$
		—	—	250		$V_{DS} = 160\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$
IGSS	Gate-to-Source Leakage Forward	—	—	100	nA	$V_{GS} = 20\text{V}$
IGSS	Gate-to-Source Leakage Reverse	—	—	-100		$V_{GS} = -20\text{V}$
Qg	Total Gate Charge	—	—	60	nC	$V_{GS} = 10\text{V}, I_D = 16\text{A}$
Qgs	Gate-to-Source Charge	—	—	10.6		$V_{DS} = 50\text{V}$
Qgd	Gate-to-Drain ('Miller') Charge	—	—	37.6		
td(on)	Turn-On Delay Time	—	—	20	ns	$V_{DD} = 100\text{V}, I_D = 16\text{A}, R_G = 9.1\Omega$
tr	Rise Time	—	—	152		
td(off)	Turn-Off Delay Time	—	—	58		
tf	Fall Time	—	—	67		
L <sub>S</sub> + L <sub>D</sub>	Total Inductance	—	6.8	—	nH	Measured from drain lead (6mm/0.25in. from package) to source lead (6mm/0.25in. from package)
C <sub>iss</sub>	Input Capacitance	—	1300	—	pF	$V_{GS} = 0\text{V}, V_{DS} = 25\text{V}$ $f = 1.0\text{MHz}$
C <sub>oss</sub>	Output Capacitance	—	400	—		
C <sub>rss</sub>	Reverse Transfer Capacitance	—	130	—		

**Source-Drain Diode Ratings and Characteristics**

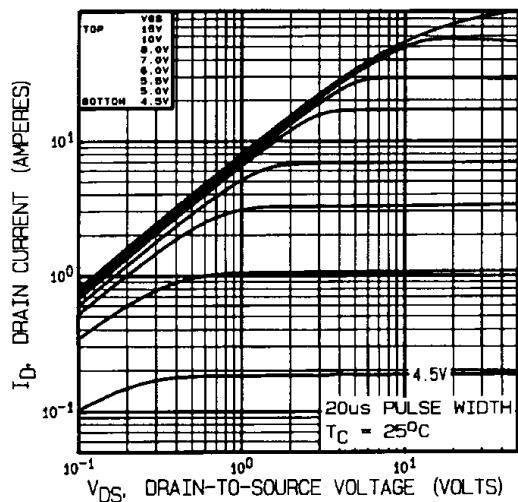
	Parameter	Min	Typ	Max	Units	Test Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	16	A	$T_J = 25^\circ\text{C}, I_S = 16\text{A}, V_{GS} = 0\text{V}$ ④
I <sub>SM</sub>	Pulse Source Current (Body Diode) ①	—	—	64		
V <sub>SD</sub>	Diode Forward Voltage	—	—	1.5	V	
t <sub>rr</sub>	Reverse Recovery Time	—	—	500	nS	$T_J = 25^\circ\text{C}, I_F = 16\text{A}, dI/dt \leq 100\text{A}/\mu\text{s}$ $V_{DD} \leq 50\text{V}$ ④
Q <sub>RR</sub>	Reverse Recovery Charge	—	—	5.3	$\mu\text{C}$	
t <sub>on</sub>	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L <sub>S</sub> + L <sub>D</sub> .				

**Thermal Resistance**

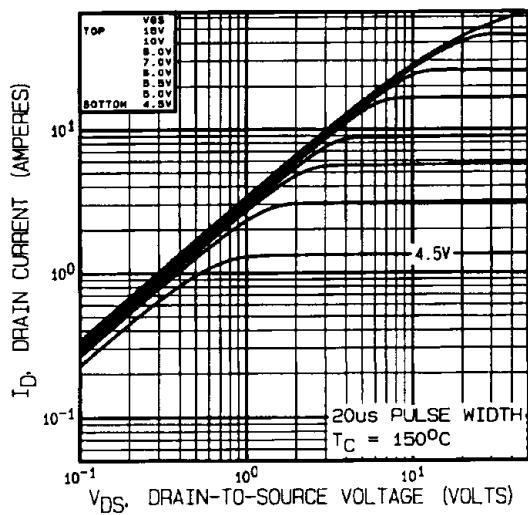
	Parameter	Min	Typ	Max	Units	Test Conditions
R <sub>thJC</sub>	Junction-to-Case	—	—	1.25	°C/W	Typical socket mount
R <sub>thCS</sub>	Case-to-sink	—	0.21	—		
R <sub>thJA</sub>	Junction-to-Ambient	—	—	80		

Note: Corresponding Spice and Saber models are available on the G&S Website.

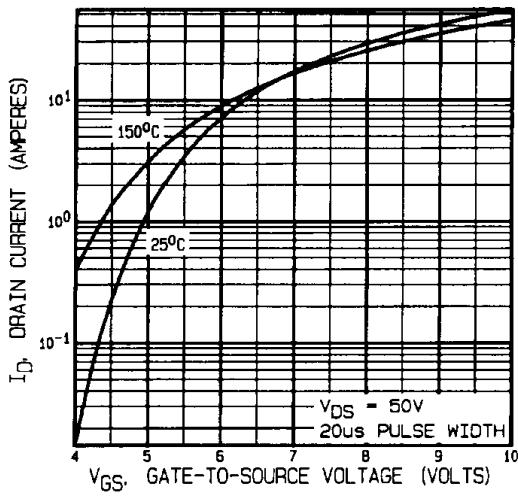
For footnotes refer to the last page



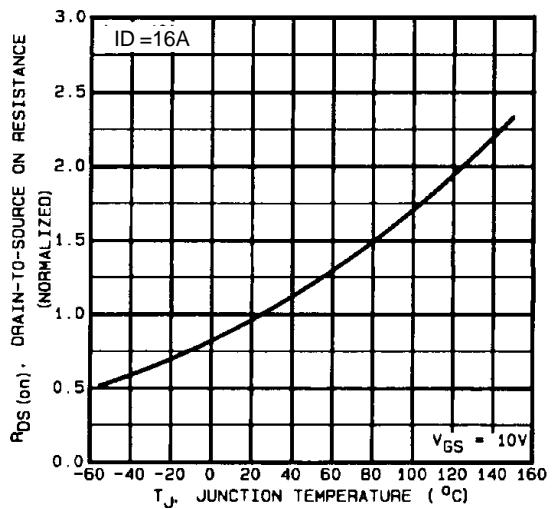
**Fig 1.** Typical Output Characteristics



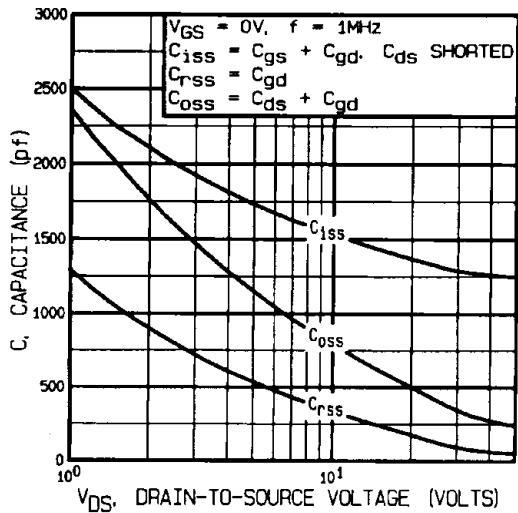
**Fig 2.** Typical Output Characteristics



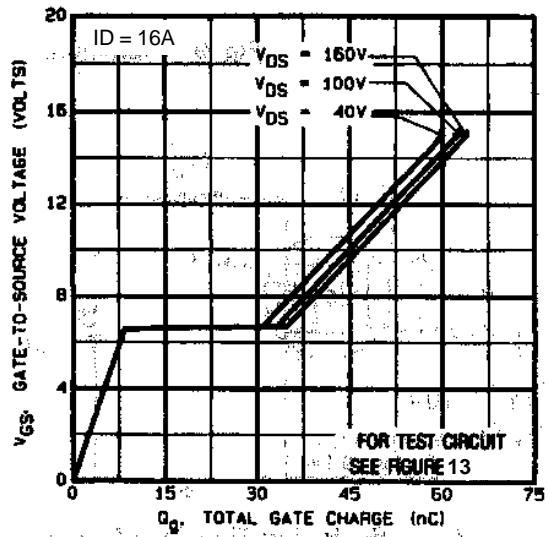
**Fig 3.** Typical Transfer Characteristics



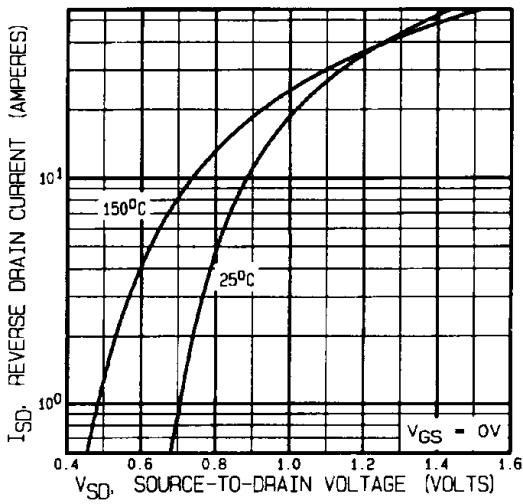
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



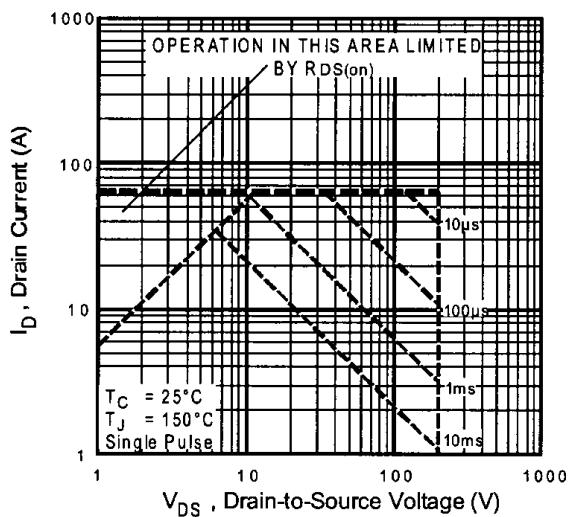
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



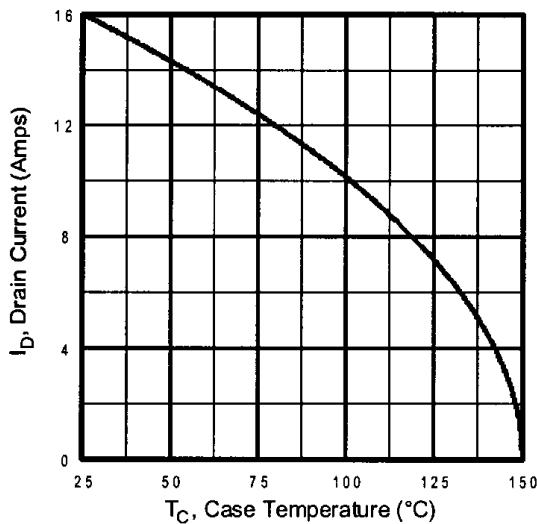
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



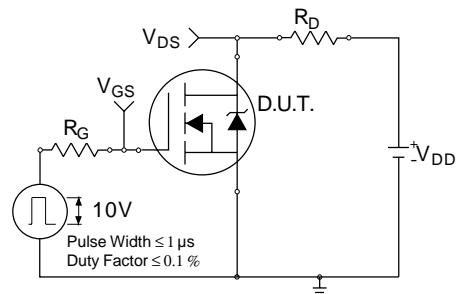
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



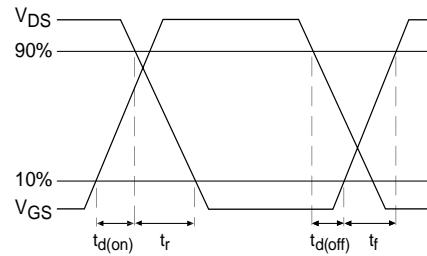
**Fig 8.** Maximum Safe Operating Area



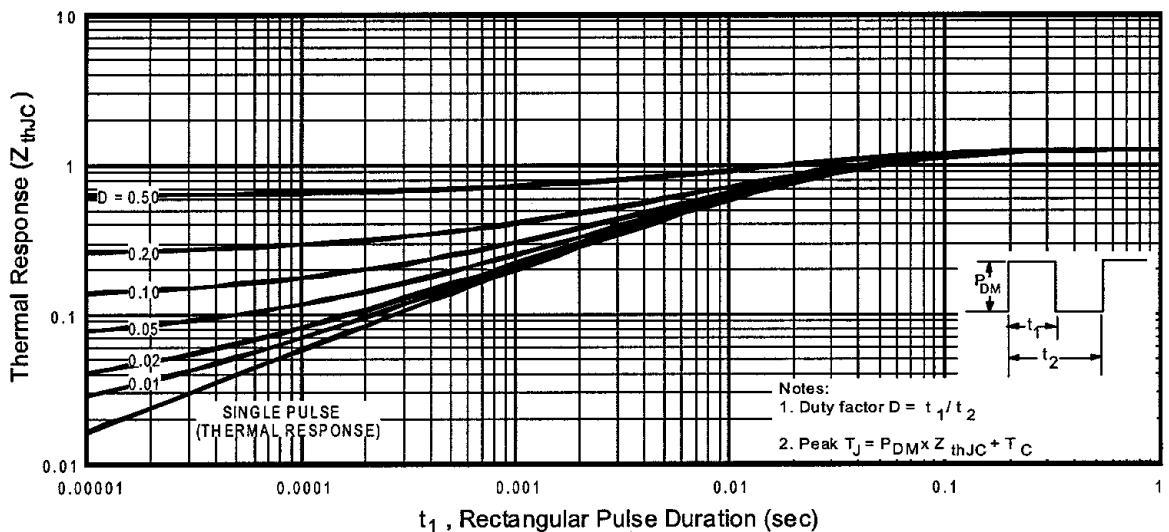
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

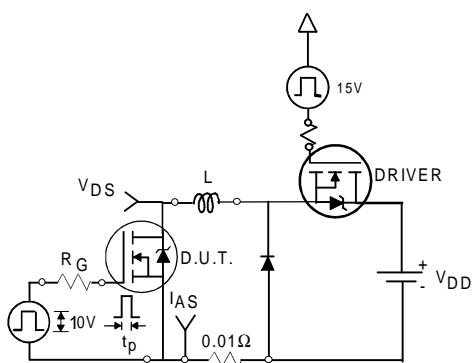


Fig 12a. Unclamped Inductive Test Circuit

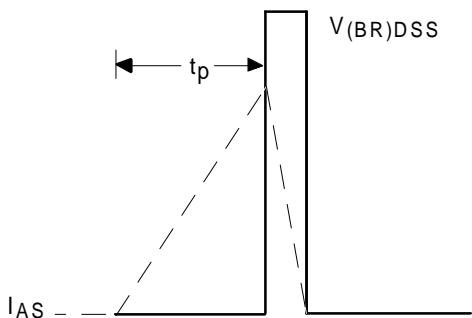


Fig 12b. Unclamped Inductive Waveforms

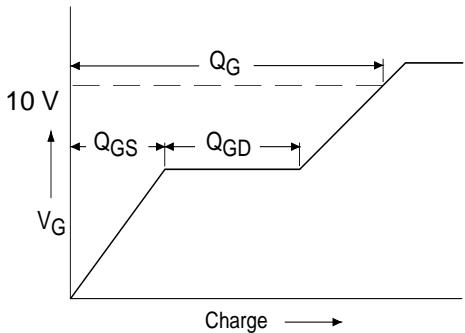


Fig 13a. Basic Gate Charge Waveform

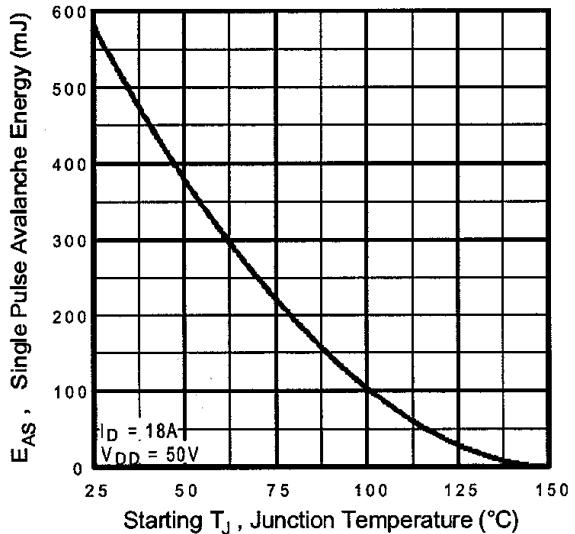


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

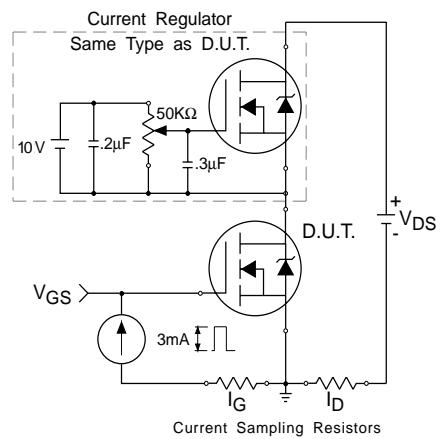


Fig 13b. Gate Charge Test Circuit

## Footnotes:

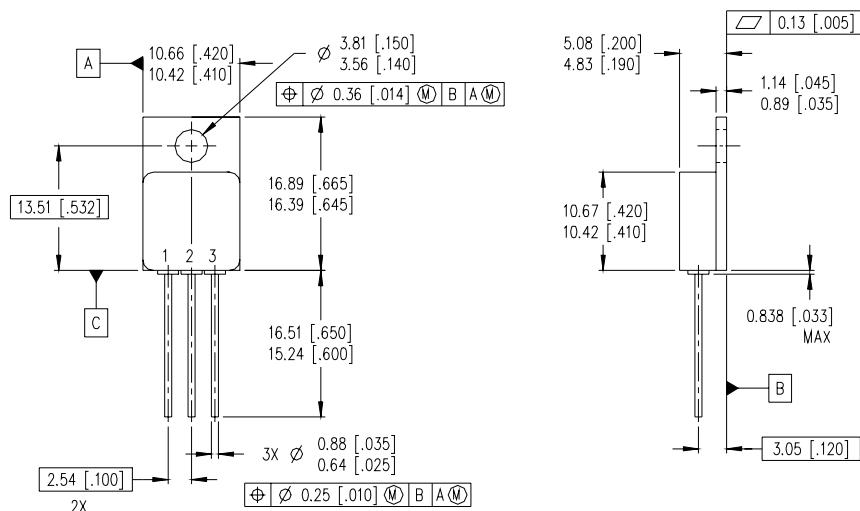
① Repetitive Rating; Pulse width limited by maximum junction temperature.

② V<sub>DD</sub> = 50V, starting T<sub>J</sub> = 25°C, L = 4.5mH  
Peak I<sub>L</sub> = 16A, V<sub>GS</sub> = 10V

③ I<sub>SD</sub> ≤ 16A, di/dt ≤ 150A/μs,  
V<sub>DD</sub> ≤ 200V, T<sub>J</sub> ≤ 150°C

④ Pulse width ≤ 300 μs; Duty Cycle ≤ 2%

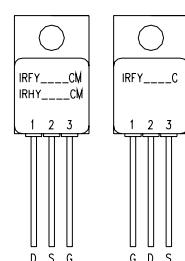
## Case Outline and Dimensions — TO-257AA



### NOTES:

1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE TO-257AA.

LEGEND  
D – DRAIN  
S – SOURCE  
G – GATE



International  
**IR** Rectifier

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TAC Fax: (310) 252-7903

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